

Silicon Carbide (SiC) MOSFET - 160 mohm, 1200 V, M1, D2PAK-7L

NVBG160N120SC1

Features

- Typ. $R_{DS(on)} = 160 \text{ m}\Omega$
- Ultra Low Gate Charge (typ. Q_{G(tot)} = 33.8 nC)
- Low Effective Output Capacitance (typ. Coss = 50.7 pF)
- 100% Avalanche Tested
- AEC-Q101 Qualified and PPAP Capable
- This Device is Halide Free and RoHS Compliant with exemption 7a, Pb–Free 2LI (on second level interconnection)

Typical Applications

- Automotive On Board Charger
- Automotive DC-DC converter for EV/HEV

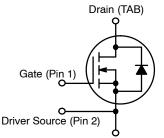
MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter		Symbol	Value	Unit	
Drain-to-Source Voltage		V_{DSS}	1200	V	
Gate-to-Source Voltage	ge		V_{GS}	-15/+25	٧
Recommended Operation Values of Gate–Source Voltage		V_{GSop}	-5/+20	V	
Continuous Drain Current (Note 1)	Steady T _C = 25°C		I _D	19.5	Α
Power Dissipation (Note 1)			P _D	136	W
Continuous Drain Current (Note 1)	Steady State	T _C = 100°C	I _D	13.7	Α
Power Dissipation (Note 1)			P _D	68	W
Pulsed Drain Current (Note 2) T _A = 25°C		I_{DM}	78	Α	
Single Pulse Surge Drain Current Capability	T_A = 25°C, t_p = 10 μ s, R_G = 4.7 Ω		I _{DSC}	140	Α
Operating Junction and Storage Temperature Range		T _J , T _{stg}	-55 to +175	°C	
Source Current (Body Diode)			IS	13.6	Α
Single Pulse Drain-to-Source Avalanche Energy (I _L = 15.5 A _{pk} , L = 1 mH) (Note 3)		E _{AS}	120	mJ	
Maximum Lead Temperature for Soldering, 1/8" from Case for 10 Seconds		TL	300	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Repetitive rating, limited by max junction temperature.
- 3. E_{AS} of 120 mJ is based on starting $T_J = 25^{\circ}\text{C}$; L = 1 mH, $I_{AS} = 15.5$ A, $V_{DD} = 120$ V, $V_{GS} = 18$ V.

V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
1200 V	224 mΩ @ 20 V	19.5 A



Power Source (Pins 3, 4, 5, 6, 7)

N-CHANNEL MOSFET



D2PAK-7L CASE 418BJ

MARKING DIAGRAM

AYWWZZ NVBG 160120SC1

A = Assembly Location

Y = Year WW = Work Week ZZ = Lot Traceability

NVBG160120SC1 = Specific Device Code

ORDERING INFORMATION

Device	Package	Shipping [†]
NVBG160N120SC1	D2PAK-7L	800 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

Table 1. THERMAL CHARACTERISTICS

Parameter	Symbol	Max	Unit
Thermal Resistance Junction-to-Case (Note 1)	$R_{ heta JC}$	1.1	°C/W
Thermal Resistance Junction-to-Ambient (Note 1)	$R_{ hetaJA}$	40	°C/W

Table 2. ELECTRICAL CHARACTERISTICS (T_{.1} = 25°C unless otherwise stated)

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
OFF CHARACTERISTICS			l .			
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D = 1 mA	1200			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J	I _D = 1 mA, refer to 25°C		0.7		V/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 \text{ V}, \qquad T_{J} = 25^{\circ}\text{C}$			100	μΑ
		$V_{DS} = 1200 \text{ V}$ $T_{J} = 175^{\circ}\text{C}$			1	mA
Gate-to-Source Leakage Current	I _{GSS}	$V_{GS} = +25/-15 \text{ V}, V_{DS} = 0 \text{ V}$			±1	μΑ
ON CHARACTERISTICS (Note 2)					•	
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 2.5 \text{ mA}$	1.8	3	4.3	V
Recommended Gate Voltage	V_{GOP}		-5		+20	V
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 20 V, I _D = 12 A, T _J = 2	25°C	160	224	mΩ
		$V_{GS} = 20 \text{ V}, I_D = 12 \text{ A}, T_J = 12 \text{ A}$	175°C	239	365	mΩ
Forward Transconductance	9FS	V _{DS} = 10 V, I _D = 12 A		5.5		S
CHARGES, CAPACITANCES & GATE RES	STANCE		,			
Input Capacitance	C _{ISS}	$V_{GS} = 0 \text{ V, f} = 1 \text{ MHz,}$		678		pF
Output Capacitance	C _{OSS}	V _{DS} = 800 V		50.7		
Reverse Transfer Capacitance	C _{RSS}			5.87		
Total Gate Charge	Q _{G(TOT)}	$V_{GS} = -5/20 \text{ V}, V_{DS} = 600 \text{ V}$,	33.8		nC
Threshold Gate Charge	Q _{G(TH)}	I _D = 16 A		6.1		
Gate-to-Source Charge	Q _{GS}			11.6		
Gate-to-Drain Charge	Q_{GD}			9.6		
Gate-Resistance	R_{G}	f = 1 MHz		1.39		Ω
SWITCHING CHARACTERISTICS			•			
Turn-On Delay Time	t _{d(ON)}	V _{GS} = -5/20 V, V _{DS} = 800 V,		11	20	ns
Rise Time	t _r	I_D = 16 A, R_G = 6 Ω , Inductive Load		11	20	
Turn-Off Delay Time	t _{d(OFF)}			15	27	
Fall Time	t _f			7.4	15	
Turn-On Switching Loss	E _{ON}			120		μJ
Turn-Off Switching Loss	E _{OFF}			28		_
Total Switching Loss	E _{TOT}			148		
DRAIN-SOURCE DIODE CHARACTERIST			<u> </u>			
Continuous Drain-Source Diode Forward Current	I _{SD}	$V_{GS} = -5 \text{ V}, T_{J} = 25^{\circ}\text{C}$			13.6	Α
Pulsed Drain-Source Diode Forward Current (Note 2)	I _{SDM}	V_{GS} = -5 V, T_J = 25°C			78	Α
Forward Diode Voltage	V_{SD}	V _{GS} = -5 V, I _{SD} = 6 A, T _J = 2	25°C	3.9		V

Table 2. ELECTRICAL CHARACTERISTICS (T_{.1} = 25°C unless otherwise stated) (continued)

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
DRAIN-SOURCE DIODE CHARACTER	ISTICS					
Reverse Recovery Time	t _{RR}	$V_{GS} = -5/20 \text{ V}, I_{SD} = 16 \text{ A},$		15		ns
Reverse Recovery Charge	Q _{RR}	- dl _S /dt = 1000 A/μs		47		nC
Reverse Recovery Energy	E _{REC}			3.9		μJ
Peak Reverse Recovery Current	I _{RRM}			6.6		Α
Charge Time	Ta			7.0		ns
Discharge Time	Tb			7.4		ns

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL CHARACTERISTICS

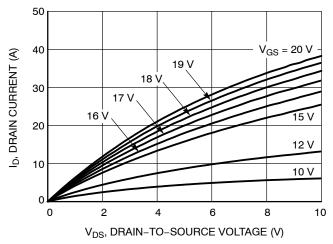


Figure 1. On-Region Characteristics

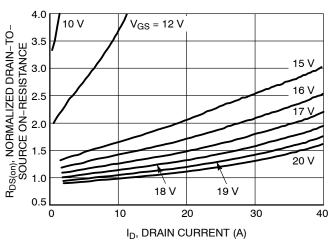


Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage

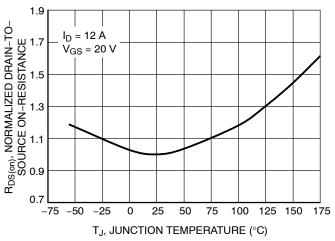


Figure 3. On–Resistance Variation with Temperature

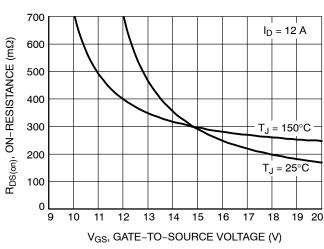


Figure 4. On-Resistance vs. Gate-to-Source Voltage

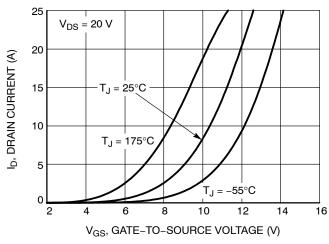


Figure 5. Transfer Characteristics

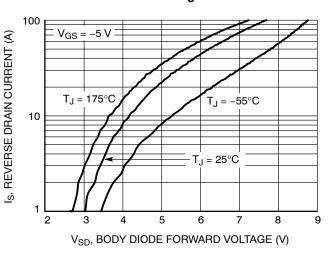


Figure 6. Diode Forward Voltage vs. Current

TYPICAL CHARACTERISTICS (continued)

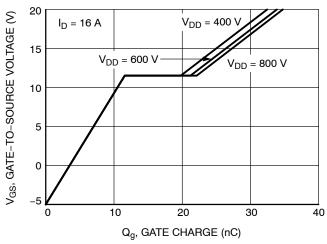


Figure 7. Gate-to-Source Voltage vs. Total Charge

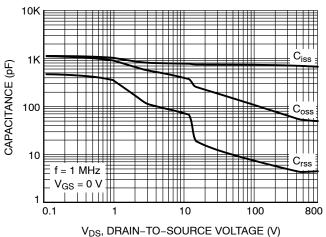


Figure 8. Capacitance vs. Drain-to-Source
Voltage

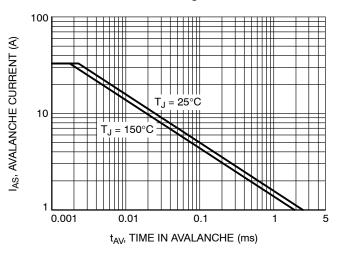


Figure 9. Unclamped Inductive Switching Capability

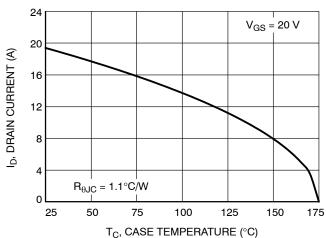


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

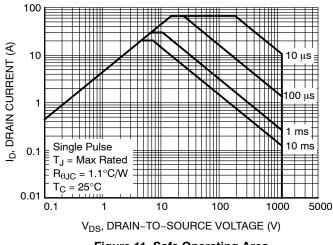


Figure 11. Safe Operating Area

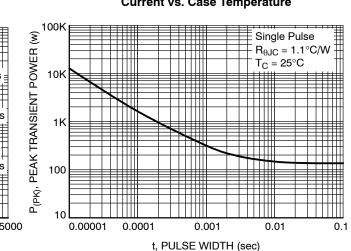


Figure 12. Single Pulse Maximum Power Dissipation

TYPICAL CHARACTERISTICS (continued)

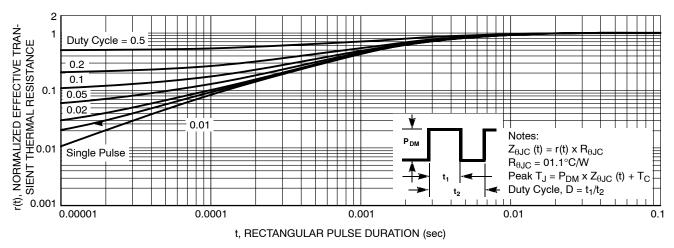


Figure 13. Junction-to-Ambient Transient Thermal Response Curve

D²PAK7 (TO-263-7L HV) CASE 418BJ **ISSUE B**

DATE 16 AUG 2019

NOTES:

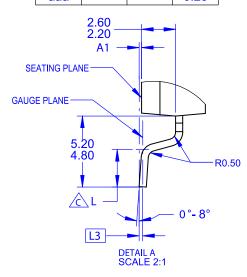
A. PACKAGE CONFORMS TO JEDEC TO-263 VARIATION CB EXCEPT WHERE NOTED. B. ALL DIMENSIONS ARE IN MILLIMETERS.

OUT OF JEDEC STANDARD VALUE.

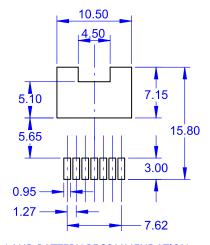
D. DIMENSION AND TOLERANCE AS PER ASME Y14.5-2009.

E. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR PROTRUSIONS.

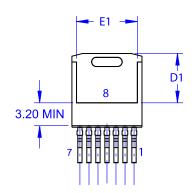
DIM	MILLIMETERS				
DIM	MIN	NOM	MAX		
Α	4.30	4.50	4.70		
A1	0.00	0.10	0.20		
b2	0.60	0.70	0.80		
b	0.51	0.60	0.70		
С	0.40	0.50	0.60		
c2	1.20	1.30	1.40		
D	9.00	9.20	9.40		
D1	6.15	6.80	7.15		
Е	9.70	9.90	10.20		
E1	7.15	7.65	8.15		
е	~	1.27	~		
Н	15.10	15.40	15.70		
L	2.44	2.64	2.84		
L1	1.00	1.20	1.40		
L3	~	0.25	~		
aaa	~	~	0.25		

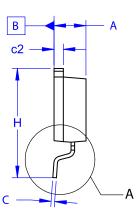


A	E L1
D	
<u> </u>	
b2 —	
e aaa B	b — A M



LAND PATTERN RECOMMENDATION





GENERIC MARKING DIAGRAM*



XXXX = Specific Device Code = Assembly Location

= Year WW = Work Week G = Pb-Free Package

*This information is generic. Please refer to

device data sneet for actual part marking.
Pb-Free indicator, "G" or microdot "■", may
or may not be present. Some products may
not follow the Generic Marking.

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